

12V P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)} max	I _D max T _A = 25°C
-12V	16mΩ @ $V_{GS} = -4.5V$	-9.1A
	21.5mΩ @ V _{GS} = -2.5V	-7.9A
	26mΩ @ V _{GS} = -1.8V	-7.0A
	$32mΩ @ V_{GS} = -1.5V$	-6.3A

Description

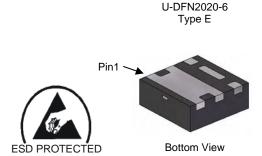
This MOSFET has been designed specifically for use in battery management applications.

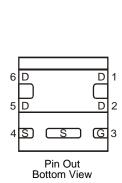
Features

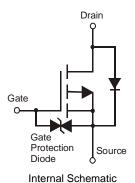
- 0.6mm profile ideal for low profile applications
- PCB footprint of 4mm²
- Low Gate Threshold Voltage
- Fast Switching Speed
- ESD Protected to 3KV
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: U-DFN2020-6 Type E
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.0065 grams (approximate)







July 2012

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Ordering Information (Note 4)

Part Number	Marking	Reel size (inches)	Quantity per reel
DMP1022UFDE-7	P4	7	3,000

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com.

Marking Information



P4 = Product Type Marking Code YM = Date Code Marking Y = Year (ex: Y = 2011) M = Month (ex: 9 = September)

Date Code Key

Year	201	1	2012		2013	20	14	2015		2016	2	2017
Code	Υ		Z		Α	E	3	С		D		Е
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

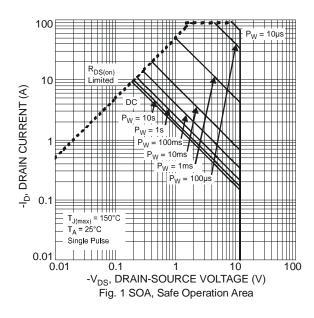
Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V_{DSS}	-12	V		
Gate-Source Voltage	V_{GSS}	±8	V		
Continuous Prain Current (Note C) V 4 5V	$T_A = +25$ °C $T_A = +70$ °C	I _D	-9.1 -7.2	А	
Continuous Drain Current (Note 6) V _{GS} = -4.5V	t<5s	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	-11.2 -9.0	А
Pulsed Drain Current (10µs pulse, duty cycle = 1%)	I_{DM}	-90	Α		
Continuous Source-Drain Diode Current	Is	-2.5 -7.1	А		
Pulsed Source-Drain Diode Current (10µs pulse, duty	I _{SM}	-50	A		

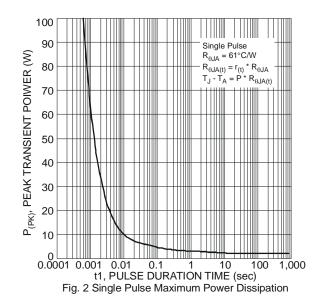
Thermal Characteristics

Characteristic		Symbol	Value	Units
Total Dower Dissipation (Note 5)	$T_A = +25$ °C	Pn	0.66	W
Total Power Dissipation (Note 5)	T _A = +70°C		0.42	VV
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	<u> </u>	189	°C/W
mermai Resistance, Junction to Ambient (Note 5)	t<5s	$R_{\theta JA}$	123	
Total Power Dissipation (Note 6)	$T_A = +25$ °C	נ	2.03	W
Total Power Dissipation (Note 6)	$T_A = +70^{\circ}C$	P_{D}	1.3	
Thermal Resistance, Junction to Ambient (Note 6)	Steady state	Б	61	
memai Resistance, Junction to Ambient (Note 6)	t<5s	$R_{\theta JA}$	40	°C/W
Thermal Resistance, Junction to Case (Note 6)	Steady state	$R_{ heta JC}$	9.3	
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C

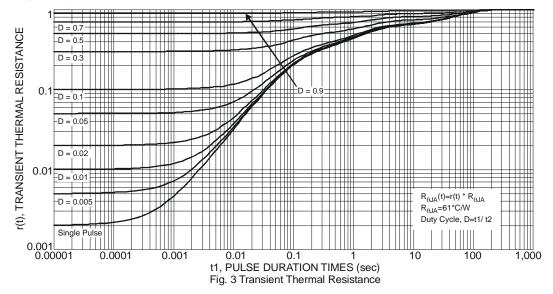
Notes:

- 5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal vias to bottom layer 1inch square copper plate









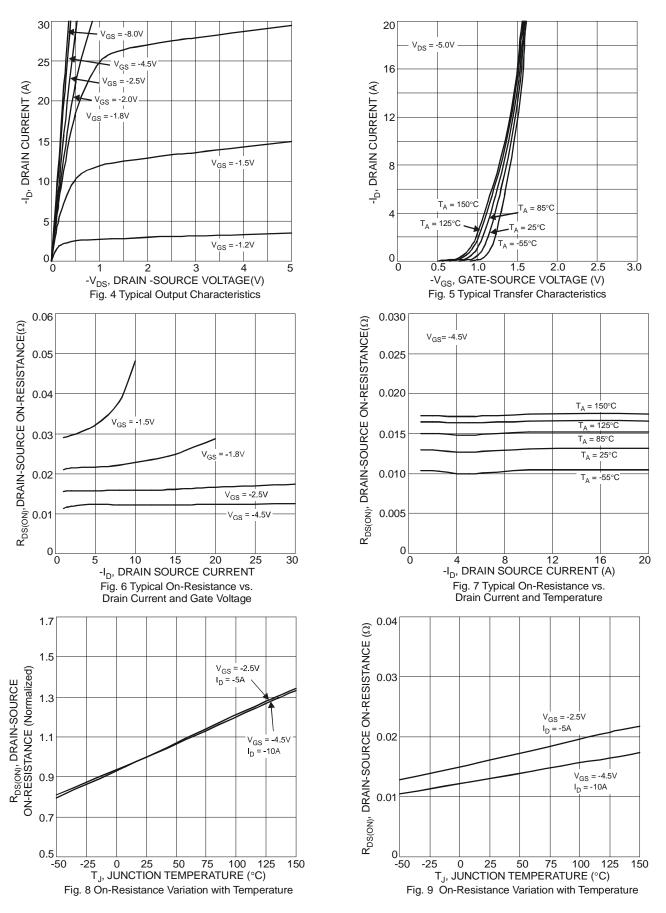
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

OFF CHARACTERISTICS (Note 7) Drain-Source Breakdown Voltage BV _{DSS} -12 — — V Zero Gate Voltage Drain Current T _J = +25°C I _{DSS} — — -1 µA Gate-Source Leakage I _{GSS} — — ±2 µA ON CHARACTERISTICS (Note 7) Gate Threshold Voltage V _{GS(th)} ΔT _J - 2.5 — mV°C Quality Temperature Coefficient ΔV _{GS(th)} ΔT _J - 2.5 — mV°C On-State Drain Current I _{D(ON)} -10 — — A Static Drain-Source On-Resistance R _{DS (ON)} — 20 26 mΩ° Static Drain-Source On-Resistance R _{DS (ON)} — 20 26 mΩ° Static Drain-Source On-Resistance R _{DS (ON)} — 20 26 mΩ° Static Drain-Source On-Resistance IYfs — 12 16 15 15 21.5 S S Forward Transfer Admittance IYfs —	Test Condition						
Zero Gate Voltage Drain Current T _J = +25°C I _{DSS} — — — 1 μA	Characteristic Symbol Min Typ Max Unit Test Condition OFF CHARACTERISTICS (Note 7)						
Gate-Source Leakage I _{GSS}	$V_{GS} = 0V, I_D = -250\mu A$						
ON CHARACTERISTICS (Note 7) Gate Threshold Voltage V _{GS(th)} -0.35 — -0.8 V V _{GS(th)} Temperature Coefficient ΔV _{GS(th)} /ΔTJ - 2.5 — mV/°C On-State Drain Current ID(ON) -10 — — A Static Drain-Source On-Resistance RDS (ON) — 20 26 mΩ Static Drain-Source On-Resistance IP(Is) — 20 26 mΩ Static Drain-Source On-Resistance IP(Is) — 20 26 mΩ Static Drain-Source On-Resistance IP(Is) — 20 26 mΩ Bolode Forward Voltage VSD — -0.8 -1.2 V DYNAMIC CHARACTERISTICS (Note 8) Input Capacitance Ciss — 2953 — Input Capacitance Ciss — 2953 — pF Reverse Transfer Capacitance Ciss — 2953 — pF Reverse Transfer Capacitance Rq — 8.6	$V_{DS} = -12V, V_{GS} = 0V$						
Gate Threshold Voltage	$V_{GS} = \pm 5V, V_{DS} = 0V$						
VGS(th) Temperature Coefficient ΔVGS(th) ΔTJ - 2.5							
Vostimic Production Constitution Constitutio	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$						
Static Drain-Source On-Resistance R _{DS} (ON)	$I_D = -250 \mu A$						
Static Drain-Source On-Resistance R _{DS (ON)}	$V_{GS} = -4.5V, V_{DS} < -5A$						
Static Drain-Source On-Resistance R _{DS (ON)}	$V_{GS} = -4.5V, I_D = -8.2A$						
23 32 46 95	$V_{GS} = -2.5V, I_D = -7.2A$						
Forward Transfer Admittance	$V_{GS} = -1.8V, I_D = -6.6A$						
Forward Transfer Admittance	$V_{GS} = -1.5V, I_D = -1A$						
Diode Forward Voltage V _{SD} — -0.8 -1.2 V	$V_{GS} = -1.2V, I_D = -1A$						
DYNAMIC CHARACTERISTICS (Note 8) Input Capacitance Ciss — 2953 — PF	$V_{DS} = -4V, I_{D} = -8.2A$						
Input Capacitance	$V_{GS} = 0V, I_{S} = -8A$						
Output Capacitance Coss — 756 — pF Reverse Transfer Capacitance Crss — 678 — Gate Resistance R _g — 8.6 18 Ω Total Gate Charge Q _g — 28.4 42.6 42.6 42.6 42.6 42.6 42.6 42.3 42.6 42.6 42.6 42.3							
Reverse Transfer Capacitance Crss — 678 — Gate Resistance R _g — 8.6 18 Ω	N/ 4N/ N/ 0N/						
Gate Resistance R _g — 8.6 18 Ω Total Gate Charge Q _g — 28.4 42.6 Total Gate Charge Q _g — 25.3 38 Gate-Source Charge Q _{gs} — 2.3 — Gate-Drain Charge Q _{gd} — 7.2 — Turn-On Delay Time t _{D(on)} — 20 30 Turn-On Rise Time t _r — 28 42 Turn-Off Delay Time t _{D(off)} — 117 176 Turn-Off Fall Time t _f — 93 139 BODY DIODE CHARACTERISTICS Diode Forward Voltage V _{SD} — -0.8 -1.2 V Continuous Source-Drain Diode Current (Note 6) I _S	$V_{DS} = -4V, V_{GS} = 0V,$ f = 1.0MHz						
Total Gate Charge Qg	1 - 1.000112						
Total Gate Charge Q _g — 25.3 38 C Gate-Source Charge Q _{gs} — 2.3 — Gate-Drain Charge Q _{gd} — 7.2 — Turn-On Delay Time t _{D(on)} — 20 30 Turn-On Rise Time t _r — 28 42 Turn-Off Delay Time t _f — 93 139 E E E E E E E E E	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$						
Gate-Source Charge Qgs — 2.3 — nC	$V_{GS} = -5V$, $V_{DS} = -4$, $I_{D} = -10A$						
	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\						
	$V_{GS} = -4.5V, V_{DS} = -4V,$ $I_{D} = -10A$						
Turn-On Rise Time	ID = - IOA						
Turn-Off Delay Time							
Turn-Off Delay Time $t_{D(off)}$ — 117 176 Turn-Off Fall Time t_f — 93 139 BODY DIODE CHARACTERISTICS Diode Forward Voltage V_{SD} — -0.8 -1.2 V Continuous Source-Drain Diode Current (Note 6)	$V_{DS} = -4V, V_{GS} = -4.5V,$						
Turn-Off Fall Time tf — 93 139 BODY DIODE CHARACTERISTICS VSD — -0.8 -1.2 V Diode Forward Voltage VSD — -0.8 -1.2 V Continuous Source-Drain Diode Current (Note 6) Is — -2.5	$R_G = 1\Omega$, $R_L = 0.4\Omega$, $I_D = -9.8A$						
Diode Forward Voltage V _{SD} — -0.8 -1.2 V Continuous Source-Drain Diode Current (Note 6)							
Continuous Source-Drain Diode Current (Note 6)							
Continuous Source-Drain Diode Current (Note 6)	$V_{GS} = 0V, I_{S} = -9.8A$						
Continuous Source-Diam Diode Current (Note 6)	$T_A = +25$ °C						
	$T_C = +25^{\circ}C$						
Pulse Diode Forward Current (Note 8) I _{SM} — -50							
Bodyy Diode Reverse Recovery Time (Note 8) t _{rr} — 28 56							
Reverse Recovery Fall Time t _a — 10 — ns	I 0.84 dl/dt - 1004/::2						
Reverse Recovery Rise Time t _b — 18 —	$I_S = -9.8A$, $dI/dt = 100A/\mu s$						
Body Diode Reverse Recovery Charge (Note 8) Q _{rr} — 13 26 nC	7						

lotes: 7. Short duration pulse test used to minimize self-heating effect

^{8.} Guaranteed by design. Not subject to production testing







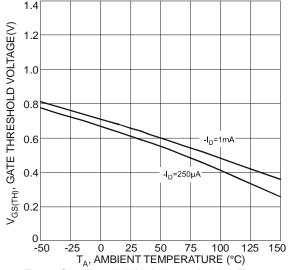
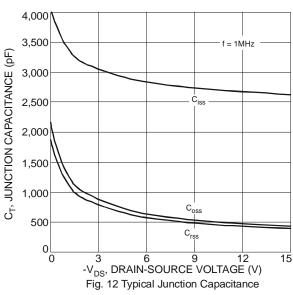
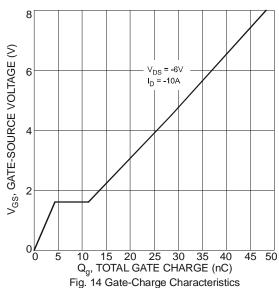
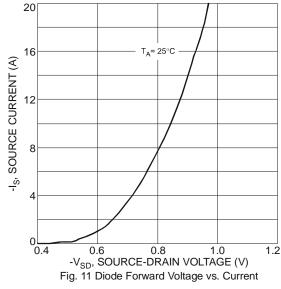


Fig. 10 Gate Threshold Variation vs. Ambient Temperature







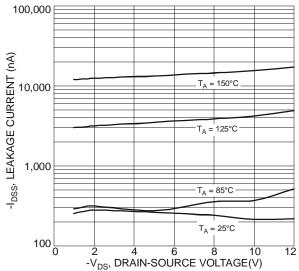
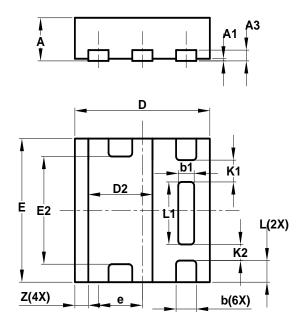


Fig. 13 Typical Drain-Source Leakage Current vs. Voltage

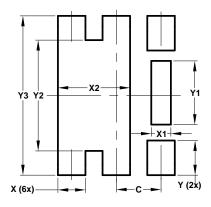


Package Outline Dimensions



U-DFN2020-6							
Type E							
Dim	Min	Min Max Typ					
Α	0.57	0.63	0.60				
A1	0	0.05	0.03				
A3	_	_	0.15				
b	0.25	0.35	0.30				
b1	0.185	0.285	0.235				
D	1.95	2.05	2.00				
D2	0.85	1.05	0.95				
Е	1.95	2.05	2.00				
E2	1.40	1.60	1.50				
е	_	_	0.65				
L	0.25	0.35	0.30				
L1	0.82	0.92	0.87				
K1	_	_	0.305				
K2	_	_	0.225				
Z	_	_	0.20				
All Dimensions in mm							

Suggested Pad Layout



Dimensions	Value
Dilliensions	(in mm)
C	0.650
Χ	0.400
X1	0.285
X2	1.050
Υ	0.500
Y1	0.920
Y2	1.600
Y3	2.300



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